

Search Notes

Application/Control No.

10/820,157

Examiner

John K. Ford

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

3744

SEARCHED

Class	Subclass	Date	Examiner
2A	above	12/06	Jef

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR